

**Search Notes**

Application/Control No.

10/674,331

Examiner

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Applicant(s)/Patent under  
Reexamination

PATEL, CHIRAG S.

Art Unit

2815

**SEARCHED**

Class	Subclass	Date	Examiner
438	460 - 462	1/18/2005	C.C.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM-TDB; and USOCR;	1/18/2005	C.C.